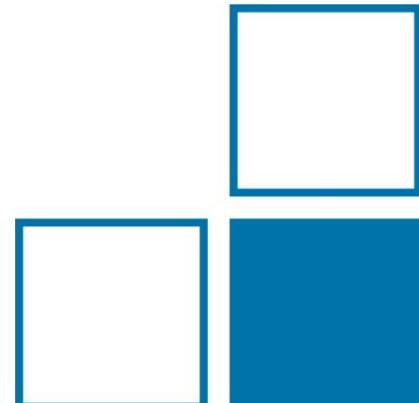


Overview of WP1

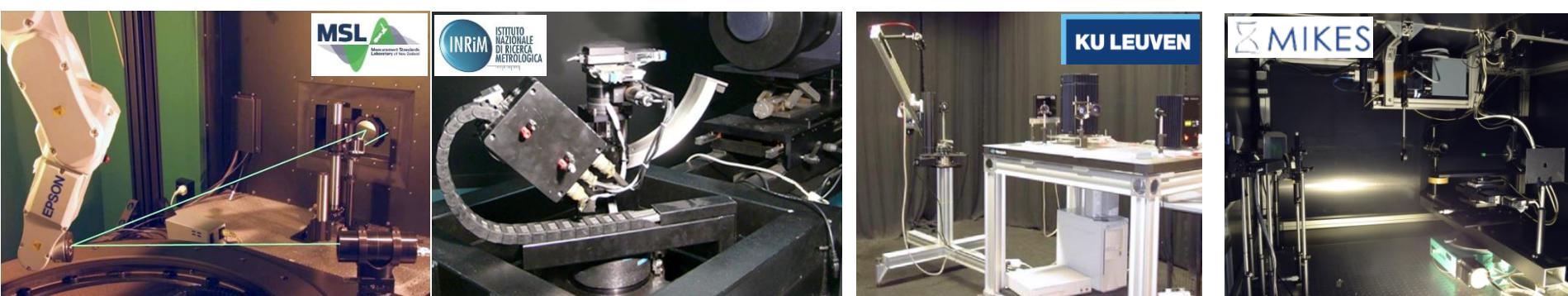
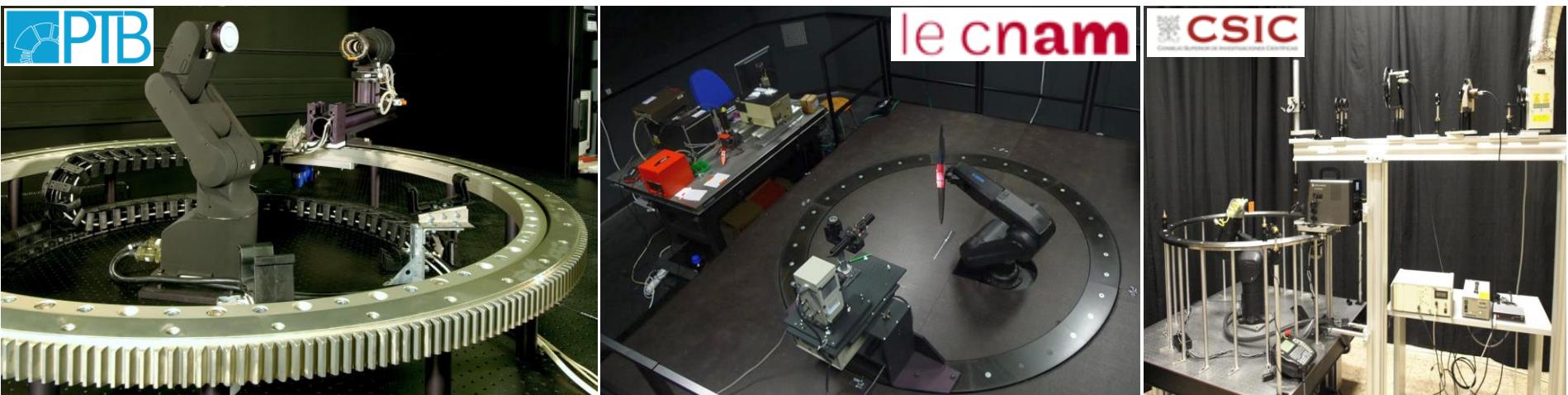
*PTB, CNAM, CMI, CSIC, INRIM, MIKES, MSL, SP, UA,
Ku Leuven*

Dr. Christian Strothkämper

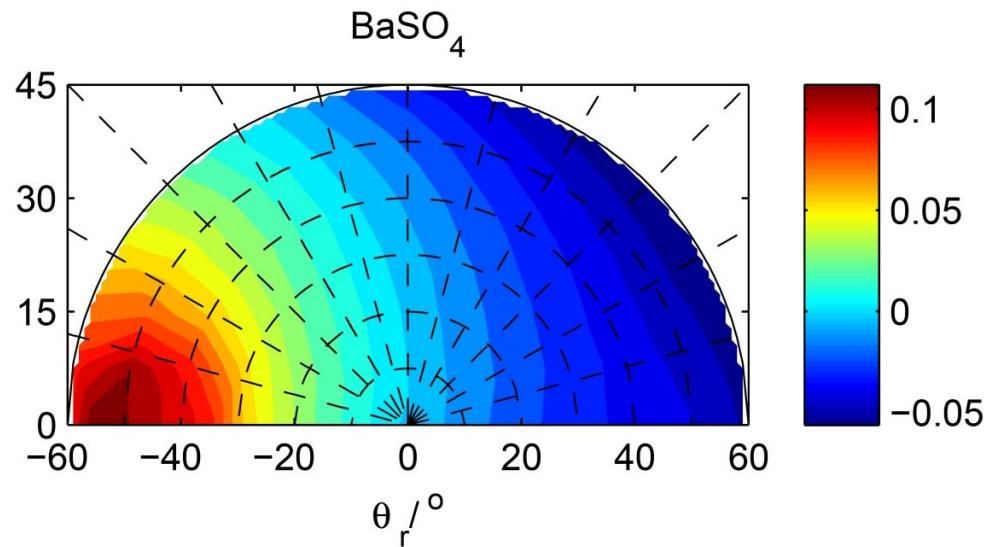
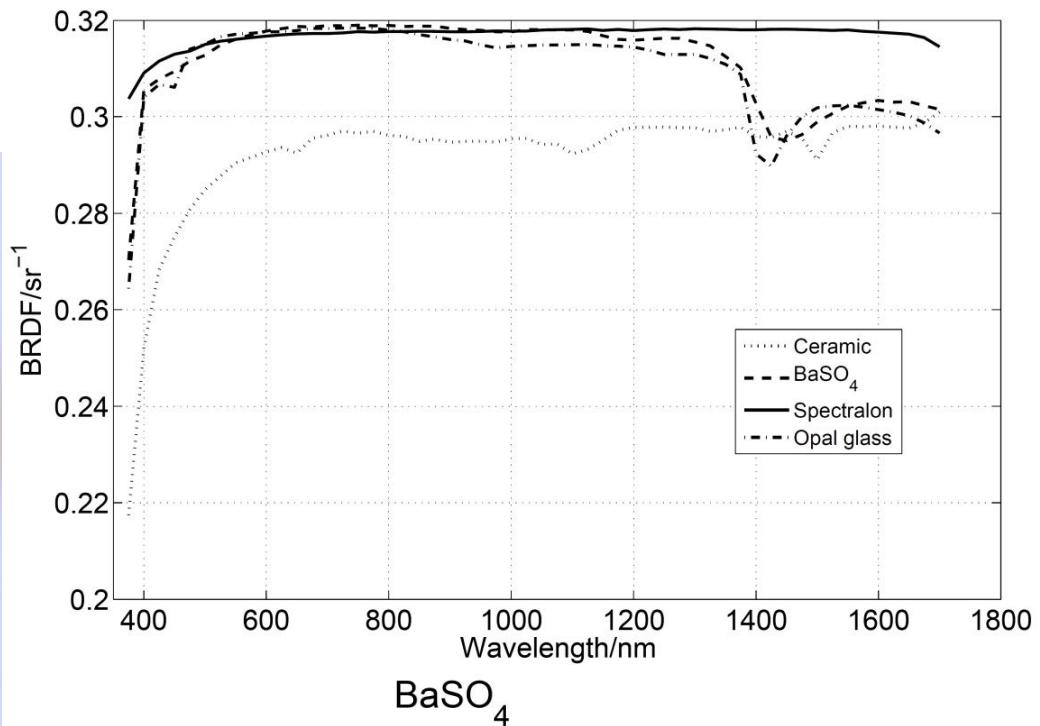
Physikalisch-Technische Bundesanstalt
WG 4.24 "Reflection and Transmission"
Bundesallee 100
38116 Braunschweig



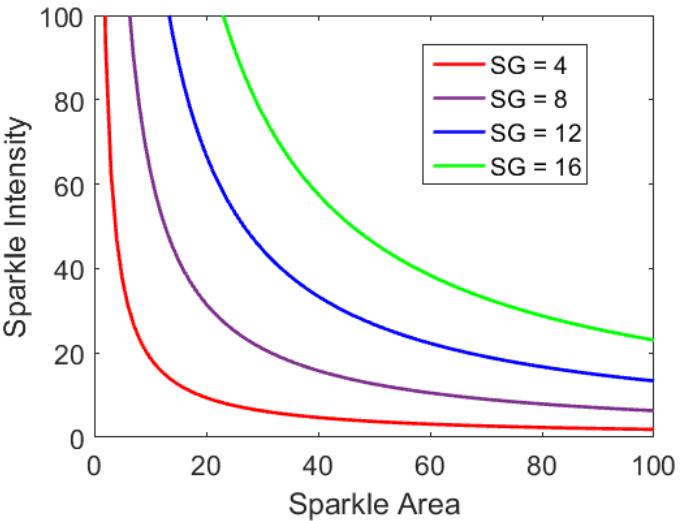
Strengthen the traceability of BRDF measurements of goniochromatic surfaces and to reduce the uncertainty of the measurement



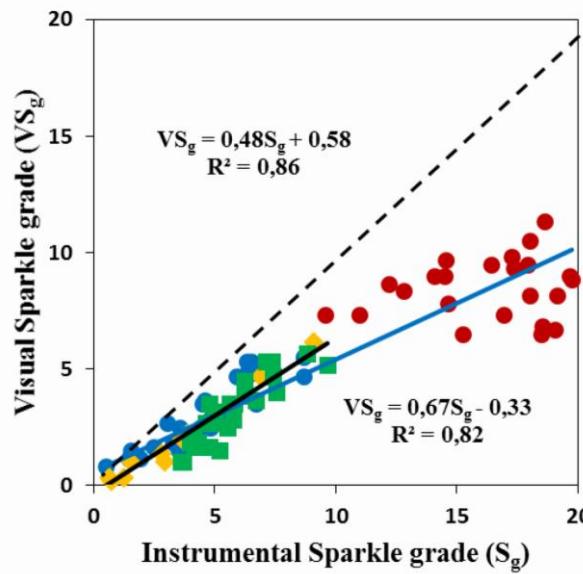
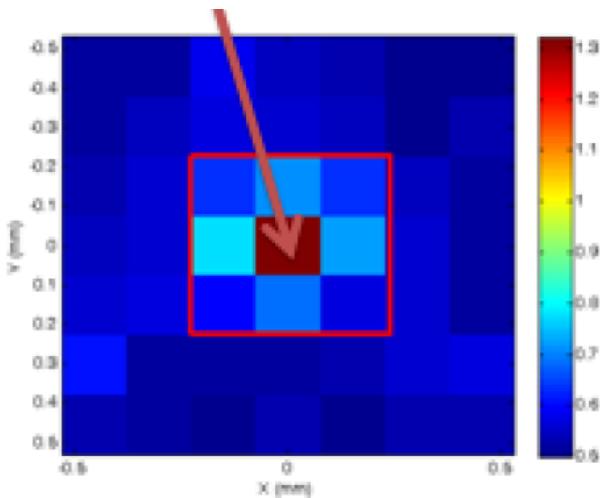
Study the non-Lambertian behavior of standard reflection materials within an extended wavelength range.



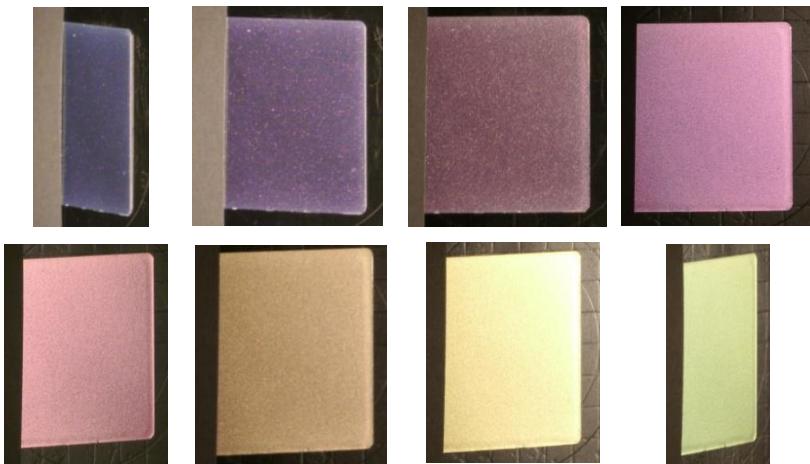
Characterization of visual appearance: Sparkle



$$S_g = 0.35\sqrt{S_i \cdot S_a} - 0.8$$



Characterization of visual appearance: Goniochromatism



Consistency analysis of multidimensional gonio-spectrophotometric measurements in interlaboratory comparisons

A. Ferrero¹, J. Campos¹, B. Bernad¹, A. Pons¹, M. L.
Hernanz¹, F. M. Martínez-Verdú² and A. Höpe^{3,†}



The screenshot shows the homepage of the xD Reflect website. At the top, there's a logo featuring a rainbow light effect and the text 'JRP - IND 52' and 'xD Reflect'. Below the logo, the text 'MULTIDIMENSIONAL REFLECTOMETRY FOR INDUSTRY' is visible. A navigation bar with links to Home, Summary, Project, Partners, Member Area, Collaborators Area, News, and Project Results. A 'Contact us' button is also present. The main content area is titled 'BRDF Data' and contains a warning message: 'Warning: Reflection standards require a calibration. The BRDF data you can find here applies only to specific samples but not to a material class. An uncertainty is not specified, the data here is only for illustrative purposes!'. Below this, there's a section titled 'Laquerings based on interference pigments' with an image of a purple surface labeled 'Chromaflair 330 - Magenta Gold'. On the right side, there are sections for 'Recent Posts' (with links to 'Next Progress r', '5th Progress m', 'CIE Tutorial on', '4th CIE Expert S', 'Visual Appearance', and 'xD Reflect at CI') and 'EMF European Metrology Programme of EA'. The background features a large, semi-transparent watermark of the letters 'EUI'.